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L Number	Hits	Search Text	DB	Time stamp
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15
PLUS Search Results for S/N 09752615, Searched August 31, 2004

The Patent Linguistics Utility System (PLUS) is a USPTO automated sear ch

system for U.S. Patents from 1971 to the present. PLUS is a query-by-example search system which produces a list of patents that a re

most closely related linguistically to the application searched. This search was prepared by the staff of the Scientific and Technical Information Center, SIRA.

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Most Frequently Occurring Classifications of Patents Returned From A Search of 09752615 on August 31, 2004

Original Classifications

- 2 710/306
- 2 714/49
- 2 714/724

Cross-Reference Classifications

- 3 365/233.
- 2 365/189.07
- 2 711/217
- 2 712/22
- 2 714/37
- 2 714/726
- 2 714/819

Combined Classifications

- 3 365/233
- 3 710/306
- 2 365/189.02
- 365/189.07
- 2 365/200
- 2 710/107
- 710/110
- 2 711/157 711/217
- 712/22
- 714/37
- 714/49
- 2 714/724
- 714/726
- 714/819

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Titles of Most Frequently Occurring Classifications of Patents Returne

From A Search of 09752615 on August 31, 2004

3	365/233 (0 OR, 3 XR) Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL 365/230.01 ADDRESSING 365/233 .Sync/clocking
3	710/306 (2 OR, 1 XR) Class 710: ELECTRICAL COMPUTERS AND DIGITAL DATA PROCESSING SYSTEMS: INPUT/OUTPUT 710/100 INTRASYSTEM CONNECTION (E.G., BUS AND BUS TRANSACTION PROCESSING) 710/305 .Bus interface architecture 710/306 .Bus bridge
2	365/189.02 (1 OR, 1 XR) Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL 365/189.01 READ/WRITE CIRCUIT 365/189.02 .Multiplexing
2	365/189.07 (0 OR, 2 XR) Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL 365/189.01 READ/WRITE CIRCUIT 365/189.07 .Including signal comparison
2	365/200 (1 OR, 1 XR) Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL 365/189.01 READ/WRITE CIRCUIT 365/200 .Bad bit
2	710/107 (1 OR, 1 XR) Class 710: ELECTRICAL COMPUTERS AND DIGITAL DATA PROCESSING SYSTEMS: INPUT/OUTPUT 710/100 INTRASYSTEM CONNECTION (E.G., BUS AND BUS TRANSACTION PROCESSING) 710/107 .Bus access regulation
2	710/110 (1 OR, 1 XR) Class 710: ELECTRICAL COMPUTERS AND DIGITAL DATA PROCESSING SYSTEMS: INPUT/OUTPUT 710/100 INTRASYSTEM CONNECTION (E.G., BUS AND BUS TRANSACTION PROCESSING) 710/107 .Bus access regulationBus master/slave controlling

2	711/157 Class 711/100 711/154 711/157	711	09752615_CLSTITLES OR, 1 XR) : ELECTRICAL COMPUTERS AND DIGITAL PROCESSING SYSTEMS: MEMORY STORAGE ACCESSING AND CONTROL .Control techniqueInterleaving
2	711/217 Class 711/200 711/217	711	: ELECTRICAL COMPUTERS AND DIGITAL PROCESSING SYSTEMS: MEMORY ADDRESS FORMATION
2	712/22 Class	(0 712	OR, 2 XR) : ELECTRICAL COMPUTERS AND DIGITAL PROCESSING SYSTEMS: PROCESSING ARCHITECTURES AND INS
TRUC	rion		
	712/1 712/10 712/16 712/22		PROCESSING PROCESSING ARCHITECTURE .Array processor .Array processor operation Single instruction, multiple data (SIMD)
2	714/37 Class 714/100	714	OR, 2 XR) : ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING
	714/1 714/25		<pre>.Reliability and availabilityFault locating (i.e., diagnosis or testing)</pre>
)	714/37		Analysis (e.g., of output, state, or design
2	714/49 Class	(2 714	OR, 0 XR) : ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY
	714/100		DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING
	714/1 714/48 714/49		.Reliability and availability.Error detection or notificationState error (i.e., content of instruction, data, or message)
2	714/724 Class	(2 714	OR, 0 XR) : ERROR DETECTION/CORRECTION AND FAULT

09752615_CLSTITLES DETECTION/RECOVERY

				DETECTION/RECOVERY
		714/699		PULSE OR DATA ERROR HANDLING
		714/724		.Digital logic testing
	2	714/726	(0 (OR, 2 XR)
		Class	714	: ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY
		714/699		PULSE OR DATA ERROR HANDLING
		714/724		.Digital logic testing
		714/726		Scan path testing (e.g., level sensitive sca
n				
				design (LSSD))
	_			
	2	714/819	•	OR, 2 XR)
		Class	714	: ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY
		714/699		PULSE OR DATA ERROR HANDLING
		714/799		.Error/fault detection technique
		714/819		Comparison of data
				-